



HALOGEN

**FREE** 

### Power MOSFET

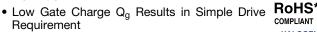
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	50	500		
R <sub>DS(on)</sub> (Max.) (Ω)	V <sub>GS</sub> = 10 V	3.0		
Q <sub>g</sub> (Max.) (nC)	17	17		
Q <sub>gs</sub> (nC)	4.3	4.3		
Q <sub>gd</sub> (nC)	8.8	8.5		
Configuration	Sinc	Single		

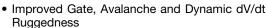
# Configuration Single D I2PAK (TO-262) D<sup>2</sup>PAK (TO-263)

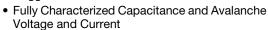
N-Channel MOSFET

#### **FEATURES**

• Halogen-free According to IEC 61249-2-21 **Definition** 







- Effective Coss specified
- Compliant to RoHS Directive 2002/95/EC

#### **APPLICATIONS**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching

#### **TYPICAL SMPS TOPOLOGIES**

- Two Transistor Forward
- · Half Bridge and Full Bridge

ORDERING INFORMATION				
Package	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)		
Lead (Pb)-free and Halogen-free	SiHF820AS-GE3	SiHF820AL-GE3		
Lead (Pb)-free	IRF820ASPbF	IRF820ALPbF		
	SiHF820AS-E3	SiHF820AL-E3		

ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, uni	iess otnerwis	se notea)		_
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	500	V
Gate-Source Voltage			V <sub>GS</sub>	± 30	7 °
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		2.5	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	ΙD	1.6	Α
Pulsed Drain Current <sup>a, e</sup>			I <sub>DM</sub>	10	
Linear Derating Factor				0.4	W/°C
Single Pulse Avalanche Energy <sup>b, e</sup>			E <sub>AS</sub>	140	mJ
Avalanche Current <sup>a</sup>			I <sub>AR</sub>	2.5	А
Repetiitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	5.0	mJ
Maximum Power Dissipation $T_C = 25  ^{\circ}C$		$P_{D}$	50	W	
Peak Diode Recovery dV/dtc, e			dV/dt	3.4	V/ns
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature) for 10 s			-	300 <sup>d</sup>	7
Mounting Torque	6 22 01	6-32 or M3 screw		10	lbf ⋅ in
Mounting Torque	0-32 OF I	VIO SCIEW		1.1	N⋅m

#### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting  $T_J = 25$  °C, L = 45 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 2.5$  A (see fig. 12).
- c.  $I_{SD} \le 2.5 \text{ A}$ ,  $dI/dt \le 270 \text{ A/}\mu\text{s}$ ,  $V_{DD} \le V_{DS}$ ,  $T_{J} \le 150 \,^{\circ}\text{C}$ .
- d. 1.6 mm from case.
- e. Uses IRF820A, SiHF820A data and test conditions.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRF820AS, SiHF820AS, IRF820AL, SiHF820AL

# Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mounted, steady-state) <sup>a</sup>	R <sub>thJA</sub>	-	62	°C/W
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	2.5	

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		·					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 250 μA		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA <sup>d</sup>		-	0.60	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.5	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 30 V	-	-	± 100	nA
Zoro Coto Voltago Drain Current		V <sub>DS</sub> :	= 500 V, V <sub>GS</sub> = 0 V	-	-	25	μА
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 \	$V_{\rm GS} = 0 \ V_{\rm T} = 125 \ ^{\circ}{\rm C}$	1	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 1.5 A <sup>b</sup>	-	-	3.0	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> :	= 50 V, I <sub>D</sub> = 1.5 A <sup>d</sup>	1.4	-	-	S
Dynamic							
Input Capacitance	$C_{iss}$		1	340	-		
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. } 5^d$		-	53	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	2.7	-	
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 1.0 \text{ V}, f = 1.0 \text{ MHz}$	1	490	-	
Output Capacitance	Ooss	$V_{GS} = 0 V$	$V_{DS} = 400 \text{ V}, f = 1.0 \text{ MHz}$	1	15	-	
Effective Output Capacitance	Coss eff.		$V_{DS} = 0 \text{ V to } 400 \text{ V}^{c, d}$	1	28	-	
Total Gate Charge	$Q_g$	V <sub>GS</sub> = 10 V		1	-	17	
Gate-Source Charge	$Q_{gs}$			1	-	4.3	nC
Gate-Drain Charge	$Q_{gd}$		see lig. 0 and 13		-	8.5	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 2.5 A,		1	8.1	-	
Rise Time	t <sub>r</sub>			1	12	-	nc
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 21 \Omega$ ,	$R_D = 97 \Omega$ , see fig. $10^{b, d}$	-	16	-	ns
Fall Time	t <sub>f</sub>			-	13	-	
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the		ı	-	2.5	Α
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	10	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	$C$ , $I_S = 2.5 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$	-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 °C 1	0 E A 41/4+ 100 A/:-b d	-	330	500	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 2.5  \text{A}, dI/dt = 100  \text{A/}\mu\text{s}^{\text{b},  \text{d}}$		-	760	1140	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )				L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .
- d. Uses IRF820A/SiHF820A data and test conditions.

#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

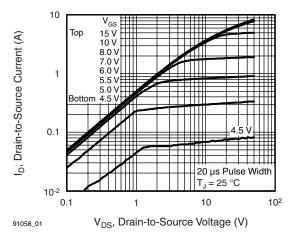


Fig. 1 - Typical Output Characteristics

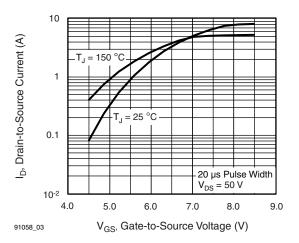


Fig. 3 - Typical Transfer Characteristics

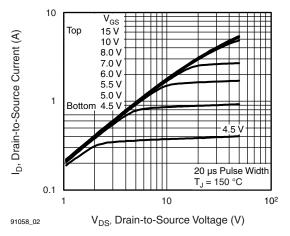


Fig. 2 - Typical Output Characteristics

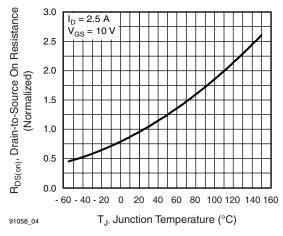


Fig. 4 - Normalized On-Resistance vs. Temperature



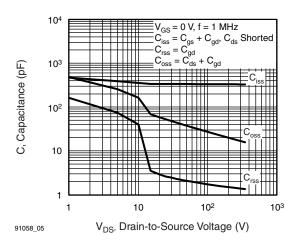


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

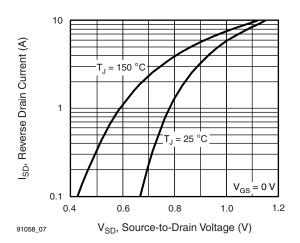


Fig. 7 - Typical Source-Drain Diode Forward Voltage

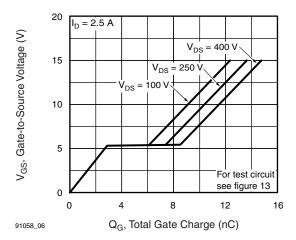


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

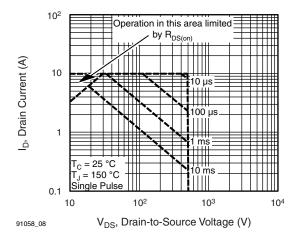


Fig. 8 - Maximum Safe Operating Area



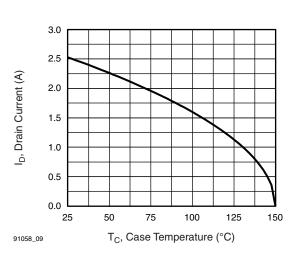


Fig. 9 - Maximum Drain Current vs. Case Temperature

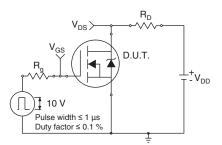


Fig. 10a - Switching Time Test Circuit

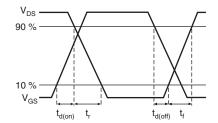


Fig. 10b - Switching Time Waveforms

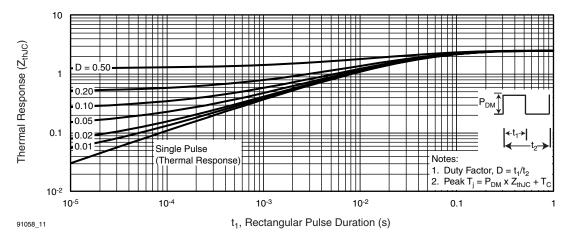


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

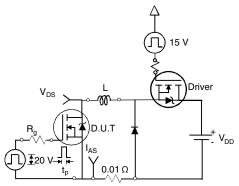


Fig. 12a - Unclamped Inductive Test Circuit

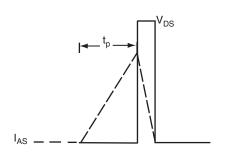


Fig. 12b - Unclamped Inductive Waveforms

# IRF820AS, SiHF820AS, IRF820AL, SiHF820AL

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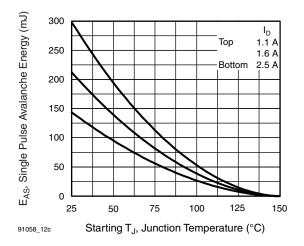


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

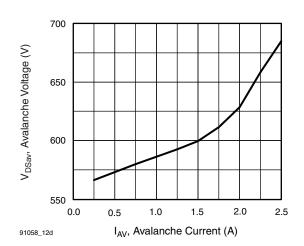


Fig. 12d - Basic Gate Charge Waveform

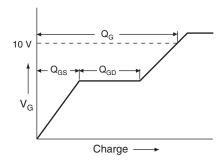


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

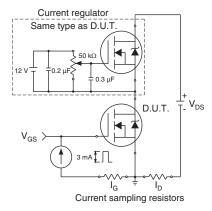
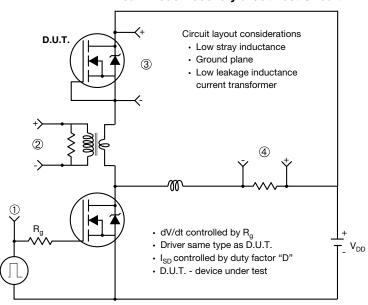


Fig. 13b - Gate Charge Test Circuit

#### Peak Diode Recovery dV/dt Test Circuit



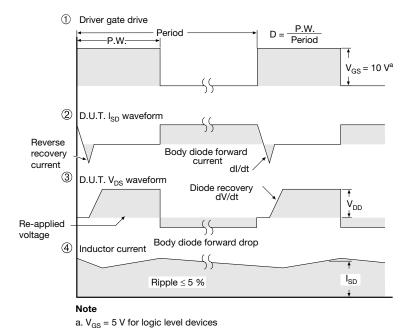
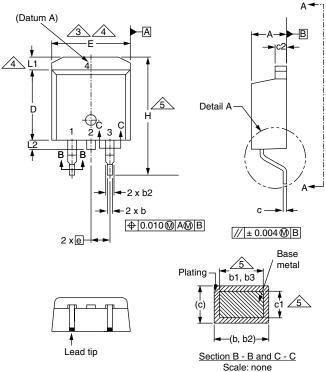


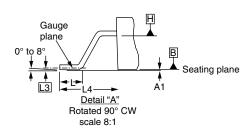
Fig. 14 - For N-Channel

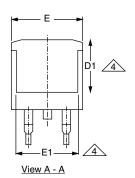
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#### **TO-263AB (HIGH VOLTAGE)**







lating –	b1, b3	/ metal
(c)		of 25
Ļ	<b>←</b> (b, b2) <b>→</b>	
Sect	ion B - B ar	
	Scale: nor	ne

	MILLIN	METERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380
ECN: S-82110-Rev. A, 15-Sep-08				

MIN. 0.270	MAX.
	-
700	
0.360	0.420
0.245	ı
0.100 BSC	
0.575	0.625
0.070	0.110
-	0.066
-	0.070
0.010	BSC
0.188	0.208
	0.100 0.575 0.070 - - 0.010

#### DWG: 5970 Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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Revision: 02-Oct-12 Document Number: 91000